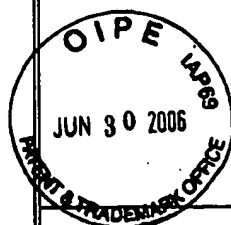


INFORMATION DISCLOSURE CITATION IN AN APPLICATION



(PTO-1449)

ATTY. DOCKET NO.
050024-0020

SERIAL NO.
10/669,639

APPLICANT
Hiroshi KANNO, et al.

FILING DATE
**September 25,
2003**

GROUP
1772 2874

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
ab		US 2004/144978		Counterpart to JP2002-251166	
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ab		JP 2002-251166	09/06/2002	Semiconductor Energy Lab Co. Ltd	With English abstract	
		JP 2002-175878	06/21/2002	Sanyo Electric Co. Ltd	With English abstract	
		JP 2001-282137	10/12/2001	Sanyo Electric Co. Ltd	With English abstract	Partial
		JP 2001-290441	10/19/2001	Sanyo Electric Co. Ltd	With English abstract	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
		Office Action, dated April 11, 2006

EXAMINER

DATE CONSIDERED

- 12/24/06

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SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
50024-020SERIAL NO.
10/669,639APPLICANT
Hiroshi KANNO, et al.FILING DATE
September 25, 2003GROUP
4772-2879

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EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
ab		JP 2001-93667 A (w/ English Abstract)	04/08/2001	SANYO ELECTRIC CO., LTD.			

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER


DATE CONSIDERED

12/24/06

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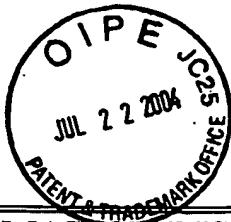
Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

INFORMATION DISCLOSURE CITATION IN AN APPLICATION 				ATTY. DOCKET NO. 050024-0020		SERIAL NO. 10/669,639		
				APPLICANT Hiroshi KANNO, et al.				
				FILING DATE September 25, 2003		GROUP 1772 2879		
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<i>ab</i>		US	6,699,739 B2	03/02/2004	Yamazaki et al.			
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<i>ab</i>		JP	2002-110345 A	04/12/2002	TOSHIBA CORP.		JAPAN (w/English Abstract and Partial Translation)	
<i>ab</i>		JP	2001-345177 A	12/14/2001	SEMICONDUCTOR ENERGY LAB CO LTD.		JAPAN (w/English Abstract)	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)								
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.						
EXAMINER				DATE CONSIDERED				
<i>Asaka</i>				12/24/06				

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SHEET 1 OF 1

INFORMATION DISCLOSURE
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(PTO-1449)

ATTY. DOCKET NO.
50024-020SERIAL NO.
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Hiroshi KANNO, et al.FILING DATE
September 25, 2003GROUP
1772-2879

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codez (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
ab		US 6,541,130 B2	4/1/2003	Fukuda	Correspondence to JP 2000-323277
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						Yes	No
ab		JP 2000-323277 A	11/24/2000	—	Correspondence to U.S. 6,541,130	U.S. corresponding Patent attached	
		JP 2003-249366 A	9/5/2003	—		Partial English Translation	
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ab		JP 2001-189192 A	7/10/2001	SEMICONDUCTOR ENERGY LAB CO LTD.		w/English Abstract	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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